Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/033,746	CHAN ET AL.	
Examiner	Art Unit	
Isaac M. Woo	2166	

SEARCHED						
Class	Subclass	Date	Examiner			
707	100-104.1	3/13/2007	ıw			
715	517-530	3/13/2007	IW			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
search - S	SPAT - text see history rintout(s)	3/13/2007	IW		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See search history printout(s), ACM, IEEE, Google	3/13/2007	IW		
Consulted with Tod Swan for 101 issue, No 101 problem	1/11/2007	IW		